

FCC Test Report

Report No. : 1812C50297912503

Applicant : Dongguan Suoai Electronics Co., LTD

Address : No.3, Huayu Street, Changlong Village,
Huangjiang Town, Dongguan City, Guangdong,
China

Product Name : Mechanical keyboard

Report Date : 2025-07-08

Shenzhen Anbotek Compliance Laboratory Limited

Shenzhen Anbotek Compliance Laboratory Limited

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TEST REPORT

Applicant : Dongguan Suoai Electronics Co., LTD
Manufacturer : Dongguan Suoai Electronics Co., LTD
Product Name : Mechanical keyboard
Model No. : F108, F108 PRO, EA75, EA75 PRO, S75 PRO, F106 PRO, S98 PRO,
F65 PRO, F65, HERO 108
Trade Mark : N/A
Rating(s) : Input: 5V=1200mA
Battery Capacity: DC 3.7V, 8000mAh
47 CFR Part 15.247
Test Standard(s) : **ANSI C63.10-2020**
KDB 558074 D01 15.247 Meas Guidance v05r02

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with above listed standard(s) requirements. This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Receipt: 2025-06-19

Date of Test: 2025-06-19 to 2025-07-01

Prepared By:

Cecilia Chen

(Cecilia Chen)

Approved & Authorized Signer:

Hugo Chen

(Hugo Chen)

Revision History

Report Version	Description	Issued Date
R00	Original Issue.	2025-07-08

Shenzhen Anbotek Compliance Laboratory Limited

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1. General Information

1.1. Client Information

Applicant	:	Dongguan Suoai Electronics Co., LTD
Address	:	No.3, Huayu Street, Changlong Village, Huangjiang Town, Dongguan City, Guangdong, China
Manufacturer	:	Dongguan Suoai Electronics Co., LTD
Address	:	No.3, Huayu Street, Changlong Village, Huangjiang Town, Dongguan City, Guangdong, China
Factory	:	Dongguan Suoai Electronics Co., LTD
Address	:	No.3, Huayu Street, Changlong Village, Huangjiang Town, Dongguan City, Guangdong, China

1.2. Description of Device (EUT)

Product Name	:	Mechanical keyboard
Model No.	:	F108, F108 PRO, EA75, EA75 PRO, S75 PRO, F106 PRO, S98 PRO, F65 PRO, F65, HERO 108 (Note: All samples are the same except the model number and appearance color, so we prepare "F108" for test only.)
Trade Mark	:	N/A
Test Power Supply	:	AC 120V/60Hz; DC 3.7V battery inside
Test Sample No.	:	1-2-1(Normal Sample), 1-2-2(Engineering Sample)
Adapter	:	N/A
RF Specification		
Operation Frequency	:	2405MHz-2475MHz
Number of Channel	:	16
Modulation Type	:	GFSK
Antenna Type	:	PCB Antenna
Antenna Gain(Peak)	:	2.34dBi
Remark: (1) All of the RF specification are provided by customer. (2) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.		

1.3. Auxiliary Equipment Used During Test

Title	Manufacturer	Model No.	Serial No.
Lenovo Computer	Lenovo	ThinkPad E485	/
PowerPort 2 Elite(24W)	Anker Innovations Limited	A2023	/

1.4. Operation channel list

Operation Band:

Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)
1	2405	5	2408	9	2414	13	2419
2	2463	6	2466	10	2471	14	2475
3	2441	7	2445	11	2459	15	2453
4	2426	8	2422	12	2436	16	2439

1.5. Description of Test Modes

Pretest Modes	Descriptions
TM1	Keep the EUT in continuously transmitting mode (non-hopping).
TM2	Keep the EUT in continuously transmitting mode (hopping).

1.6. Measurement Uncertainty

Parameter	Uncertainty
Conducted emissions (AMN 150kHz~30MHz)	3.2dB
Conducted Output Power	0.76dB
Occupied Bandwidth	925Hz
Dwell Time	2%
Conducted Spurious Emission	1.24dB
Radiated spurious emissions (above 1GHz)	1G-6GHz: 4.64dB; 6G-18GHz: 4.82dB 18G-40GHz: 5.62dB
Radiated emissions (Below 30MHz)	3.26dB
Radiated spurious emissions (30MHz~1GHz)	Horizontal: 3.70dB; Vertical: 4.42dB
The measurement uncertainty and decision risk evaluated according to AB/WI-RF-F-032. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.	

1.7. Additional Instructions

Power level setup in software: BK32xxRF Test V2.1.7

Operation Band:

Mode	Channel(MHz)	Power level	Transmitting type
2.4G	2405	default	data pack TX
2.4G	2441	default	data pack TX
2.4G	2475	default	data pack TX

1.8. Test Summary

Test Items	Test Modes	Status
Antenna requirement	/	P
Conducted Emission at AC power line	Mode1	P
Maximum Conducted Output Power	Mode1	P
Channel Separation	Mode2	P
Number of Hopping Frequencies	Mode2	P
Dwell Time	Mode2	P
Emissions in non-restricted frequency bands	Mode1,2	P
Band edge emissions (Radiated)	Mode1	P
Emissions in restricted frequency bands (below 1GHz)	Mode1	P
Emissions in restricted frequency bands (above 1GHz)	Mode1	P
Note: P: Pass N: N/A, not applicable		

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1.9. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.:279531

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 279531.

Test Location

Shenzhen Anbotek Compliance Laboratory Limited.
Sogood Industrial Zone Laboratory & 1/F. of Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Subdistrict, Bao'an District, Shenzhen, Guangdong, China.

1.10. Disclaimer

1. The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
2. The test report is invalid if there is any evidence and/or falsification.
3. The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
4. This document may not be altered or revised in any way unless done so by Anbotek and all revisions are duly noted in the revisions section.
5. Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
6. The authenticity of the information provided by the customer is the responsibility of the customer and the laboratory is not responsible for its authenticity.
7. The data in this report will be synchronized with the corresponding national market supervision and management departments and cross-border e-commerce platforms as required by regulatory agencies.

The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.



1.11. Test Equipment List

Conducted Emission at AC power line						
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.Due Date
1	L.I.S.N. Artificial Mains Network	Rohde & Schwarz	ENV216	100055	2024-09-09	2025-09-08
2	Software Name EZ-EMC	Farad Technology	ANB-03A	N/A	/	/
3	EMI Test Receiver(CE2#)	Rohde & Schwarz	ESPI3	100926	2024-09-09	2025-09-08
4	Three Phase V-type Artificial Power Network LISN 200A	EMtrace	PWL-50-3200A	2404	2025-02-21	2026-02-20

Number of Hopping Frequencies Dwell Time Emissions in non-restricted frequency bands Maximum Conducted Output Power Channel Separation						
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.Due Date
1	Constant Temperature Humidity Chamber	ZHONGJIAN	ZJ-KHWS80B	N/A	2024-10-14	2025-10-13
2	DC Power Supply	IVYTECH	IV3605	1804D360510	2024-09-09	2025-09-08
3	Spectrum Analyzer	Rohde & Schwarz	FSV40-N	102150	2025-04-25	2026-04-24
4	MXA Spectrum Analysis	KEYSIGHT	N9020A	MY50531823	2024-09-09	2025-09-08
5	Oscilloscope	Tektronix	MDO3012	C020298	2024-10-10	2025-10-09
6	MXG RF Vector Signal Generator	Agilent	N5182A	MY47420647	2025-01-14	2026-01-13

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Band edge emissions (Radiated)						
Emissions in frequency bands (above 1GHz)						
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.Due Date
1	EMI Test Receiver(RE2/3#)	Rohde & Schwarz	ESR26	101481	2025-01-14	2026-01-13
2	EMI Preamplifier	SKET Electronic	LNPA-0118G-45	SKET-PA-002	2025-01-13	2026-01-12
3	Double Ridged Horn Antenna	SCHWARZBECK	BBHA 9120D	02555	2022-10-16	2025-10-15
4	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	/	/
5	Horn Antenna	A-INFO	LB-180400-KF	J211060628	2024-01-22	2027-01-21
6	Spectrum Analyzer	Rohde & Schwarz	FSV40-N	102150	2025-04-25	2026-04-24
7	Amplifier	Talent Microwave	TLLA18G40 G-53-30	23022802	2025-02-24	2026-02-23

Emissions in frequency bands (below 1GHz)						
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.Due Date
1	EMI Test Receiver(RE2/3#)	Rohde & Schwarz	ESR26	101481	2025-01-14	2026-01-13
2	Pre-amplifier	SONOMA	310N	186860	2025-01-14	2026-01-13
3	Bilog Broadband Antenna	Schwarzbeck	VULB9163	345	2022-10-23	2025-10-22
4	Loop Antenna (9K-30M)	Schwarzbeck	FMZB1519 B	00053	2024-09-12	2025-09-11
5	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	/	/

2. Antenna requirement

Test Requirement:	Refer to 47 CFR Part 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section.
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2.1. Conclusion

The antenna is a PCB Antenna which permanently attached, and the best case gain of the antenna is 2.34dBi. It complies with the standard requirement.

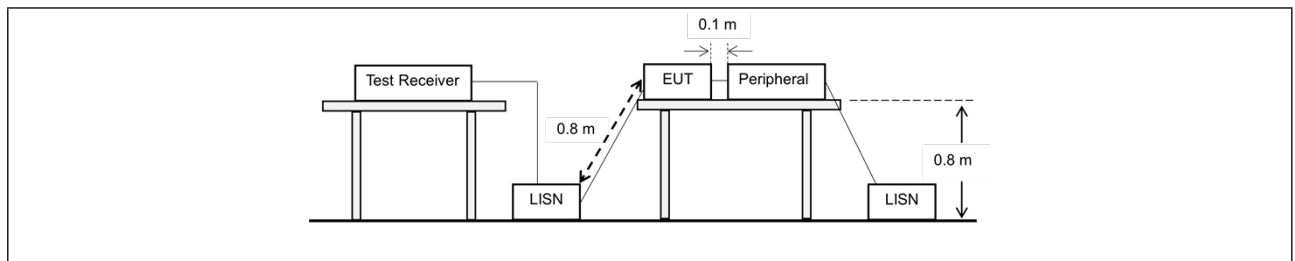
3. Conducted Emission at AC power line

Test Requirement:	Refer to 47 CFR 15.207(a), Except as shown in paragraphs (b) and (c) of this section, for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50 μ H/50 ohms line impedance stabilization network (LISN).		
Test Limit:	Frequency of emission (MHz)	Conducted limit (dB μ V)	
		Quasi-peak	Average
	0.15-0.5	66 to 56*	56 to 46*
	0.5-5	56	46
	5-30	60	50
	*Decreases with the logarithm of the frequency.		
Test Method:	ANSI C63.10-2020 section 6.2		
Procedure:	Refer to ANSI C63.10-2020 section 6.2, standard test method for ac power-line conducted emissions from unlicensed wireless devices		

3.1. EUT Operation

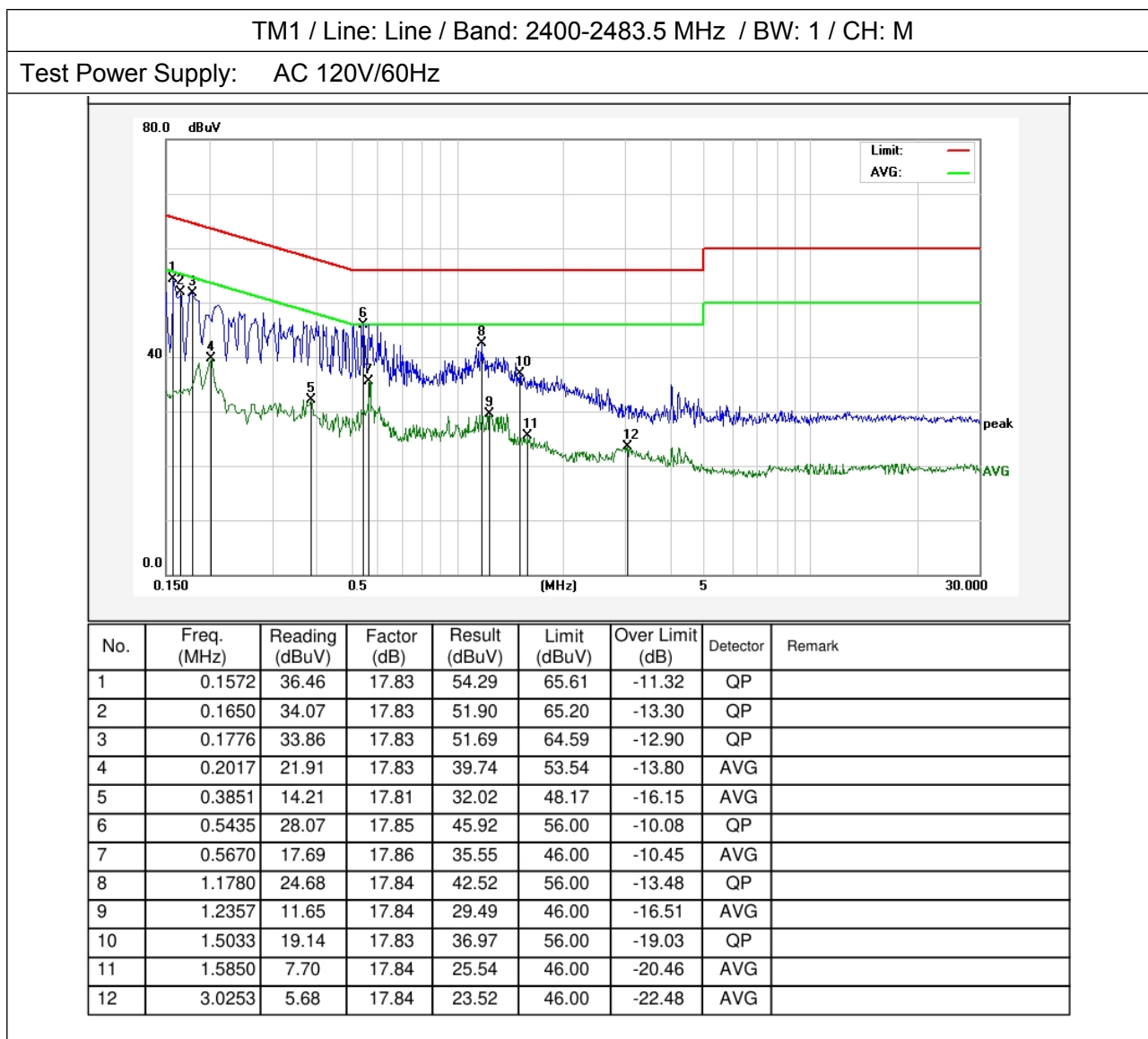
Operating Environment:	
Test mode:	1: TX (Non-Hopping): Keep the EUT in continuously transmitting mode (non-hopping).

3.2. Test Setup

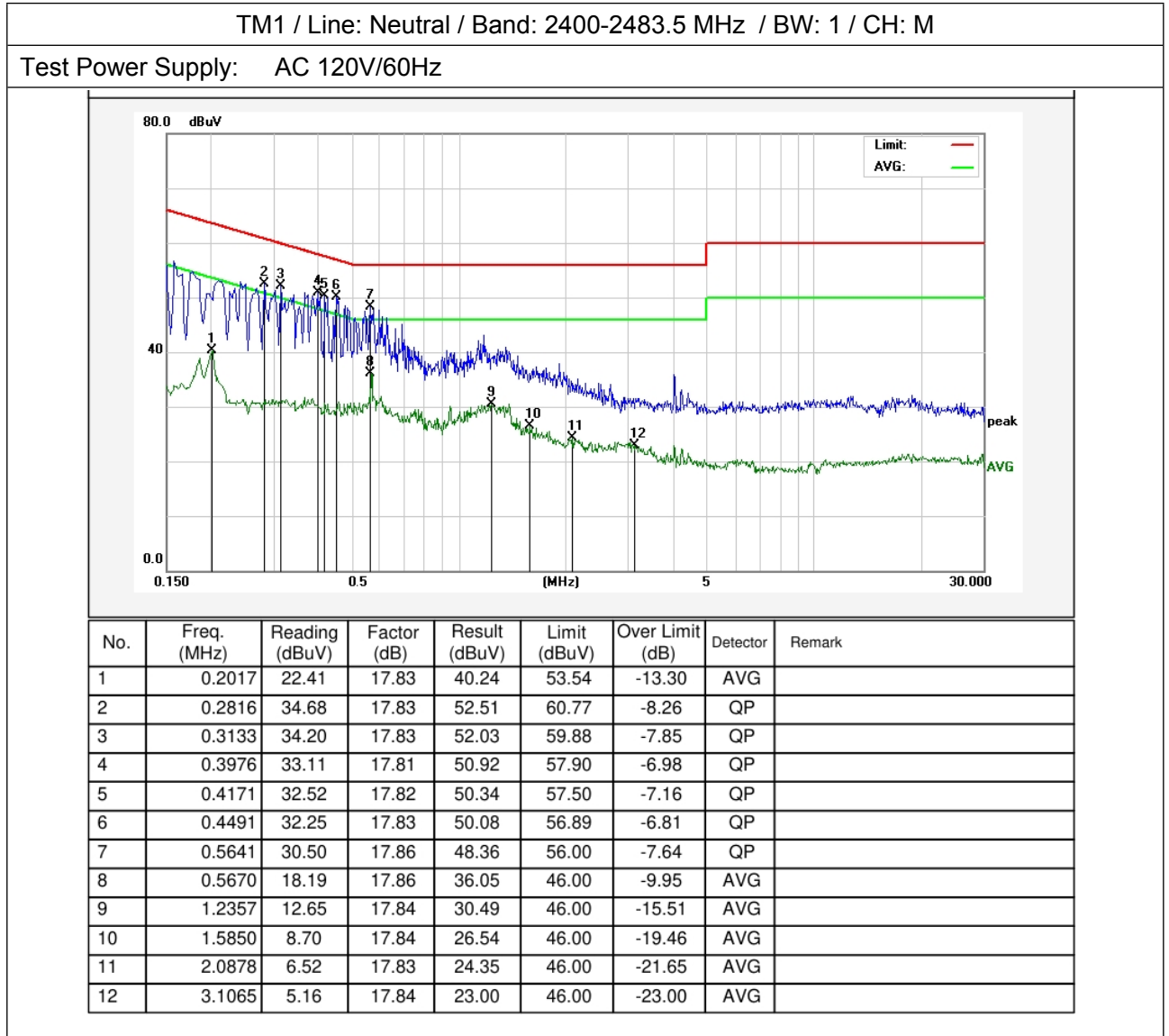


3.3. Test Data

Temperature:	25.6 °C	Humidity:	60 %	Atmospheric Pressure:	101 kPa
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Temperature:	25.6 °C	Humidity:	60 %	Atmospheric Pressure:	101 kPa
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Note:

- Only record the worst data in the report.
- Result(dBμV) = Reading(dBμV) + Factor(dB);
Over Limit(dB) = Result(dBμV) - Limit(dBμV)

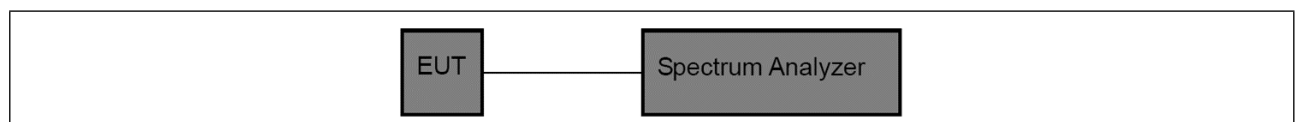
4. Maximum Conducted Output Power

Test Requirement:	47 CFR 15.247(b)(1)
Test Limit:	Refer to 47 CFR 15.247(b)(1), For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.
Test Method:	ANSI C63.10-2020, section 7.8.5 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	This is an RF-conducted test to evaluate maximum peak output power. Use a direct connection between the antenna port of the unlicensed wireless device and the spectrum analyzer, through suitable attenuation. Frequency hopping shall be disabled for this test. Use the following spectrum analyzer settings: a) Span: Approximately five times the 20 dB bandwidth, centered on a hopping channel. b) RBW > 20 dB bandwidth of the emission being measured. c) VBW ≥ RBW. d) Sweep: No faster than coupled (auto) time. e) Detector function: Peak. f) Trace: Max-hold. g) Allow trace to stabilize. h) Use the marker-to-peak function to set the marker to the peak of the emission. i) The indicated level is the peak output power, after any corrections for external attenuators and cables. j) A spectral plot of the test results and setup description shall be included in the test report. NOTE—A peak responding power meter may be used, where the power meter and sensor system video bandwidth is greater than the occupied bandwidth of the unlicensed wireless device, rather than a spectrum analyzer.

4.1. EUT Operation

Operating Environment:	
Test mode:	1: TX (Non-Hopping): Keep the EUT in continuously transmitting mode (non-hopping).

4.2. Test Setup



4.3. Test Data

Temperature:	26.1 °C	Humidity:	53 %	Atmospheric Pressure:	101 kPa
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Please Refer to Appendix for Details.

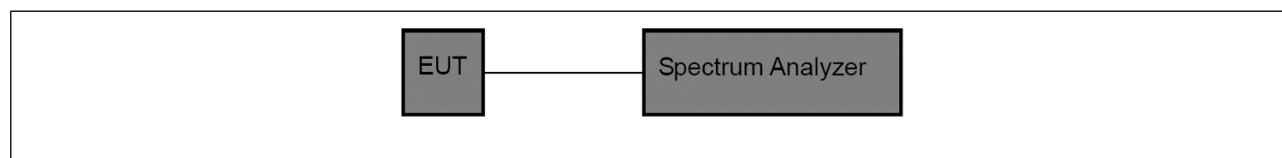
5. Channel Separation

Test Requirement:	47 CFR 15.247(a)(1)
Test Limit:	Refer to 47 CFR 15.247(a)(1), Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
Test Method:	ANSI C63.10-2020, section 7.8.2 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Wide enough to capture the peaks of two adjacent channels. b) RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel. c) Video (or average) bandwidth (VBW) $\geq$ RBW. d) Sweep: No faster than coupled (auto) time. e) Detector function: Peak. f) Trace: Max-hold. g) Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. Compliance of an EUT with the appropriate regulatory limit shall be determined. A spectral plot of the data shall be included in the test report.

5.1. EUT Operation

Operating Environment:	
Test mode:	2: TX (Hopping): Keep the EUT in continuously transmitting mode (hopping).

5.2. Test Setup



5.3. Test Data

Temperature:	26.1 °C	Humidity:	53 %	Atmospheric Pressure:	101 kPa
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Please Refer to Appendix for Details.

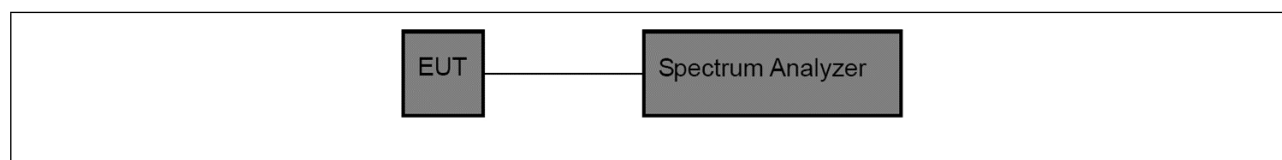
6. Number of Hopping Frequencies

Test Requirement:	47 CFR 15.247(a)(1)(iii)
Test Limit:	Refer to 47 CFR 15.247(a)(1)(iii), Frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Method:	ANSI C63.10-2020, section 7.8.3 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: The frequency band of operation. Depending on the number of channels the device supports, it could be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen. b) RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller. c) VBW $\geq$ RBW. d) Sweep: No faster than coupled (auto) time. e) Detector function: Peak. f) Trace: Max-hold. g) Allow the trace to stabilize. It might prove necessary to break the span up into subranges to show clearly all of the hopping frequencies. Compliance of an EUT with the appropriate regulatory limit shall be determined for the number of hopping channels. A spectral plot of the data shall be included in the test report.

6.1. EUT Operation

Operating Environment:	
Test mode:	2: TX (Hopping): Keep the EUT in continuously transmitting mode (hopping).

6.2. Test Setup



6.3. Test Data

Temperature:	26.1 °C	Humidity:	53 %	Atmospheric Pressure:	101 kPa
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Please Refer to Appendix for Details.

7. Dwell Time

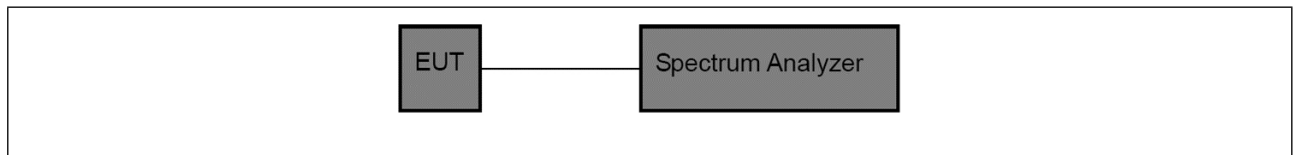
Test Requirement:	47 CFR 15.247(a)(1)(iii)
Test Limit:	Refer to 47 CFR 15.247(a)(1)(iii), Frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Method:	ANSI C63.10-2020, section 7.8.4 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	The dwell time per hop on a channel is the time from the start of the first transmission to the end of the last transmission for that hop. If the device has a single transmission per hop then the dwell time is the duration of that transmission. If the device has a multiple transmissions per hop then the dwell time is measured from the start of the first transmission to the end of the last transmission. The time of occupancy is the total time that the device dwells on a channel over an observation period specified in the regulatory requirement. To determine the time of occupancy the spectrum analyzer will be configured to measure both the dwell time per hop and the number of times the device transmits on a specific channel in a given period. The EUT shall have its hopping function enabled. Compliance with the requirements shall be made with the minimum and with the maximum number of channels enabled. If the dwell time per channel does not vary with the number of channels then compliance with the requirements may be based on the minimum number of channels. If the device supports different dwell times per channel (example Bluetooth devices can dwell on a channel for 1, 3 or 5 time slots) then measurements can be limited to the longest dwell time with the minimum number of channels. Use the following spectrum analyzer settings to determine the dwell time per hop: a) Span: Zero span, centered on a hopping channel. b) RBW shall be $\leq$ channel spacing and where possible RBW should be set $\gg 1/T$, where T is the expected transmission time per hop. c) Sweep time: Set so that the start of the first transmission and end of the last transmission for the hop are clearly captured. Setting the sweep time to be slightly longer than the hopping period per channel (hopping period = $1/\text{hopping rate}$) should achieve this. d) Use a video trigger, where possible with a trigger delay, so that the start of the transmission is clearly observed. The trigger level might need adjustment to reduce the chance of triggering when the system hops on an adjacent channel. e) Detector function: Peak. f) Trace: Clear-write, single sweep. g) Place markers at the start of the first transmission on the channel and at

	the end of the last transmission. The dwell time per hop is the time between these two markers. To determine the number of hops on a channel in the regulatory observation period repeat the measurement using a longer sweep time. When the device uses a single hopping sequence the period of measurement should be sufficient to capture at least 2 hops. When the device uses a dynamic hopping sequence, or the sequence varies, the period of measurement may need to capture multiple hops to better determine the average time of occupancy. Count the number of hops on the channel across the sweep time. The average number of hops on the same channel within the regulatory observation period is calculated from the number of hops on the channel divided by the spectrum analyzer sweep time multiplied by the regulatory observation period. For example, if three hops are counted with an analyzer sweep time of 500 ms and the regulatory observation period is 10 s, then the number of hops in that ten seconds is $3 / 0.5 \times 10$, or 60 hops. The average time of occupancy is calculated by multiplying the dwell time per hop by the number of hops in the observation period.
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7.1. EUT Operation

Operating Environment:	
Test mode:	2: TX (Hopping): Keep the EUT in continuously transmitting mode (hopping).

7.2. Test Setup



7.3. Test Data

Temperature:	26.1 °C	Humidity:	53 %	Atmospheric Pressure:	101 kPa
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Please Refer to Appendix for Details.

8. Emissions in non-restricted frequency bands

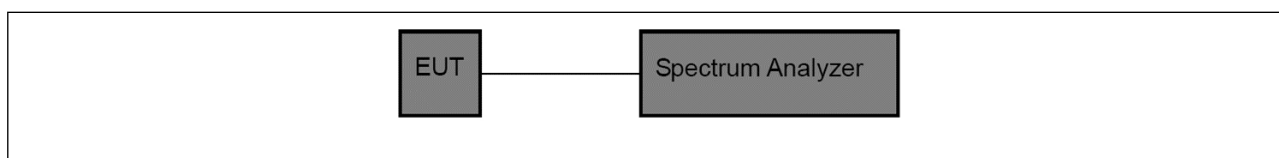
Test Requirement:	47 CFR 15.247(d)
Test Limit:	Refer to 47 CFR 15.247(d), In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.
Test Method:	ANSI C63.10-2020 section 7.8.7 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	7.8.7.1 General considerations To demonstrate compliance with the relative out-of-band emissions requirements conducted spurious emissions shall be measured for the transmit frequencies, per 5.5 and 5.6, and at the maximum transmit powers. Frequency hopping shall be disabled for this test with the exception of measurements at the allocated band-edges which shall be repeated with hopping enabled. Connect the primary antenna port through an attenuator to the spectrum analyzer input; in the results, account for all losses between the unlicensed wireless device output and the spectrum analyzer. The frequency range of testing shall span 30 MHz to 10 times the operating frequency and this may be done in a single sweep or, to aid resolution, across a number of sweeps. The resolution bandwidth shall be 100 kHz, video bandwidth 300 kHz, and a coupled sweep time with a peak detector. The limit is based on the highest in-band level across all channels measured using the same instrument settings (resolution bandwidth of 100 kHz, video bandwidth of 300 kHz, and a coupled sweep time with a peak detector). To help clearly demonstrate compliance a display line may be set at the required offset (typically 20 dB) below the highest in-band level. Where the highest in-band level is not clearly identified in the out-of-band measurements a separate spectral plot showing the in-band level shall be provided. When conducted measurements cannot be made (for example a device with integrated, non-removable antenna) radiated measurements shall be used. The reference level for determining the limit shall be established by maximizing the field strength from the highest power channel and measuring using the resolution and video bandwidth settings and peak detector as described above. The field strength limit for spurious emissions outside of restricted-bands shall then be set at the required offset (typically 20 dB) below the highest in-band level. Radiated measurements will follow the standards measurement procedures described in Clause 6 with the

	exception that the resolution bandwidth shall be 100 kHz, video bandwidth 300 kHz, and a coupled sweep time with a peak detector. Note that use of wider measurement bandwidths are acceptable for measuring the spurious emissions provided that the peak detector is used and that the measured value of spurious emissions are compared to the highest in-band level measured with the 100 kHz / 300 kHz bandwidth settings to determine compliance. 7.8.7.2 Band-edges Compliance with a relative limit at the band-edges (e.g., -20 dBc) shall be made on the lowest and on the highest channels with frequency hopping disabled and repeated with frequency hopping enabled. For the latter test the hopping sequence shall include the lowest and highest channels. For measurements with the hopping disabled the analyzer screen shall clearly show compliance with the requirement within 10 MHz of the allocated band-edge. For measurements with the hopping enabled the analyzer screen shall clearly show compliance with the requirement within 10 MHz of both of the allocated band-edges. This could require separate spectral plots for each band-edge.
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8.1. EUT Operation

Operating Environment:	
Test mode:	1: TX (Non-Hopping): Keep the EUT in continuously transmitting mode (non-hopping). 2: TX (Hopping): Keep the EUT in continuously transmitting mode (hopping).

8.2. Test Setup



8.3. Test Data

Temperature:	26.1 °C	Humidity:	53 %	Atmospheric Pressure:	101 kPa
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Please Refer to Appendix for Details.

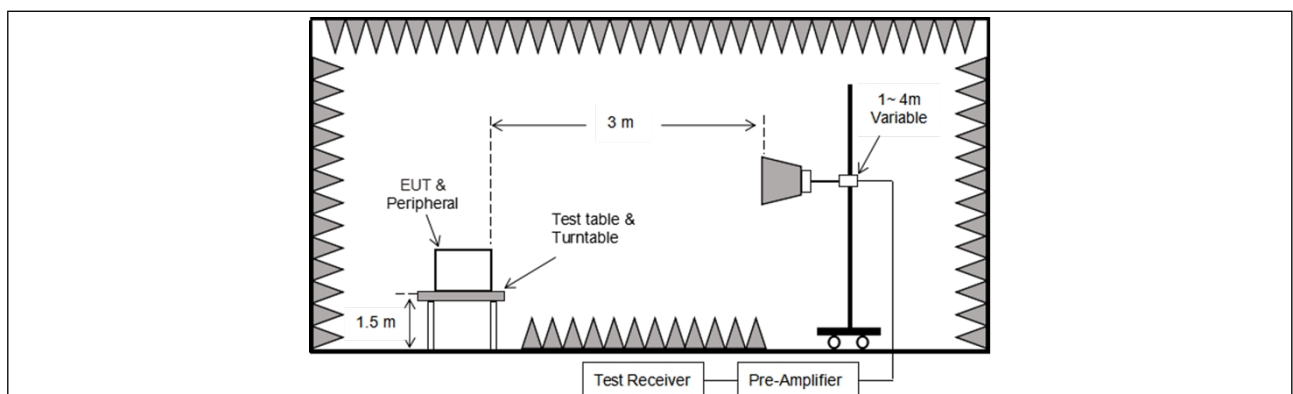
9. Band edge emissions (Radiated)

Test Requirement:	Refer to 47 CFR 15.247(d), In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a)(see § 15.205(c)).`		
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)
	0.009-0.490	2400/F(kHz)	300
	0.490-1.705	24000/F(kHz)	30
	1.705-30.0	30	30
	30-88	100 **	3
	88-216	150 **	3
	216-960	200 **	3
	Above 960	500	3
** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241. In the emission table above, the tighter limit applies at the band edges. The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9–90 kHz, 110–490 kHz and above 1000 MHz. Radiated emission limits in these three bands are based on measurements employing an average detector.			
Test Method:	ANSI C63.10-2020 section 6.10 KDB 558074 D01 15.247 Meas Guidance v05r02		
Procedure:	ANSI C63.10-2020 section 6.10.5.2		

9.1. EUT Operation

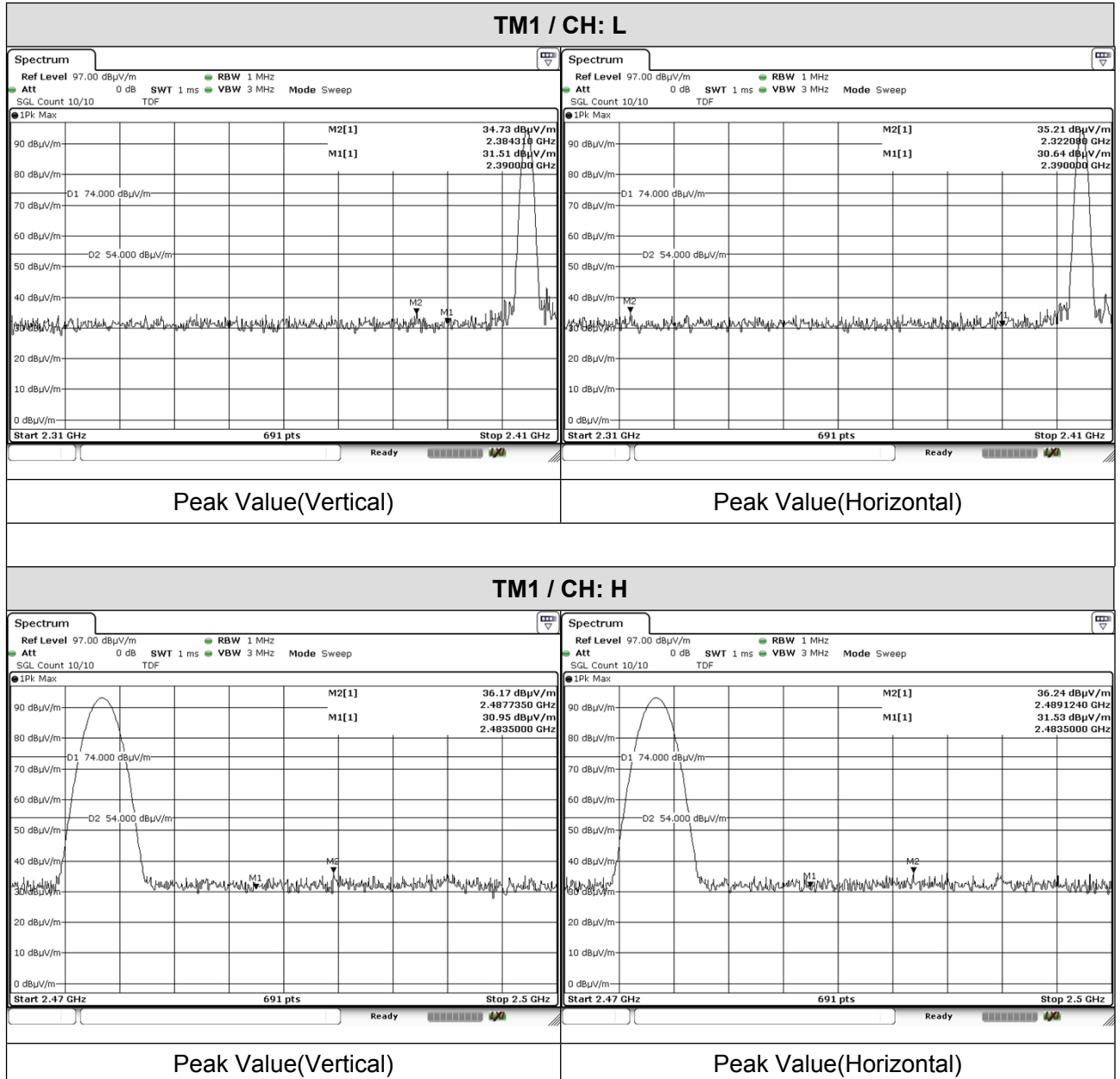
Operating Environment:	
Test mode:	1: TX (Non-Hopping): Keep the EUT in continuously transmitting mode (non-hopping).

9.2. Test Setup



9.3. Test Data

Temperature:	26.1 °C	Humidity:	53 %	Atmospheric Pressure:	101 kPa
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Note: When the PK measure result value is less than the AVG limit value, the AV measure result values test not applicable.

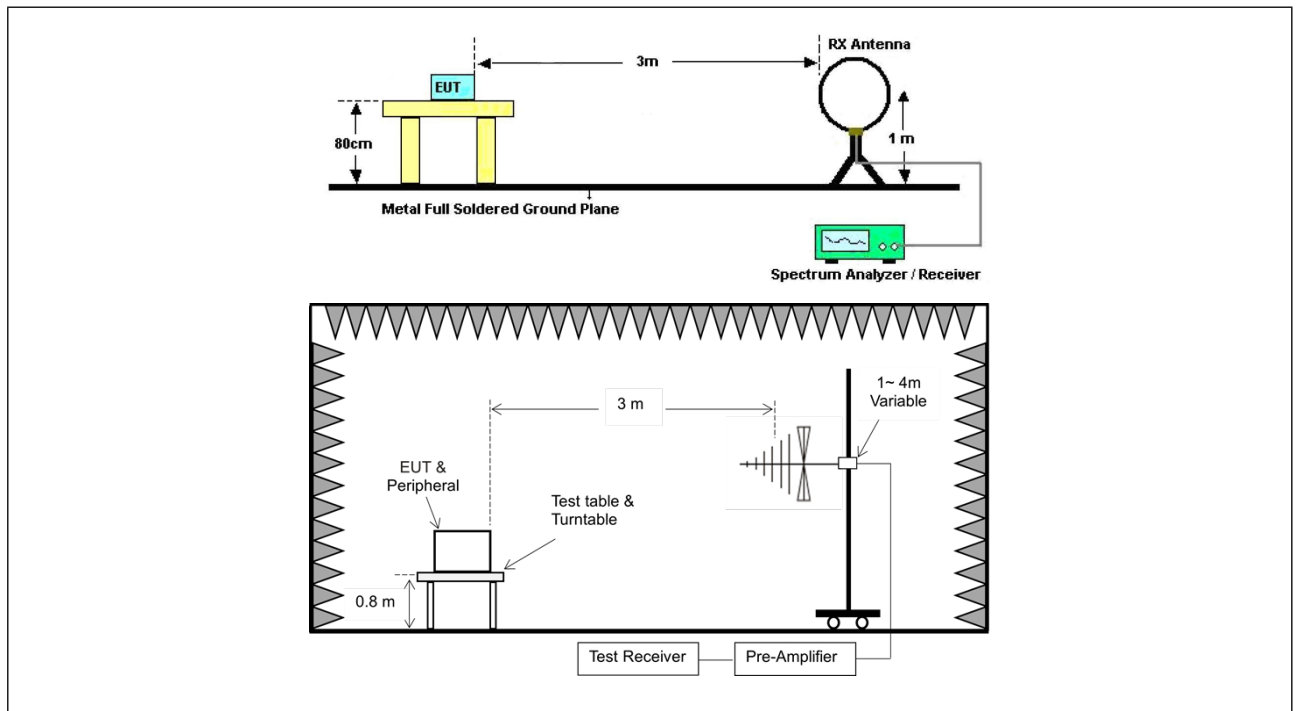
10. Emissions in restricted frequency bands (below 1GHz)

Test Requirement:	Refer to 47 CFR 15.247(d), In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a)(see § 15.205(c)).`		
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)
	0.009-0.490	2400/F(kHz)	300
	0.490-1.705	24000/F(kHz)	30
	1.705-30.0	30	30
	30-88	100 **	3
	88-216	150 **	3
	216-960	200 **	3
	Above 960	500	3
** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241. In the emission table above, the tighter limit applies at the band edges. The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9–90 kHz, 110–490 kHz and above 1000 MHz. Radiated emission limits in these three bands are based on measurements employing an average detector.			
Test Method:	ANSI C63.10-2020 section 6.6.4 KDB 558074 D01 15.247 Meas Guidance v05r02		
Procedure:	ANSI C63.10-2020 section 6.6.4		

10.1. EUT Operation

Operating Environment:	
Test mode:	1: TX (Non-Hopping): Keep the EUT in continuously transmitting mode (non-hopping).

10.2. Test Setup



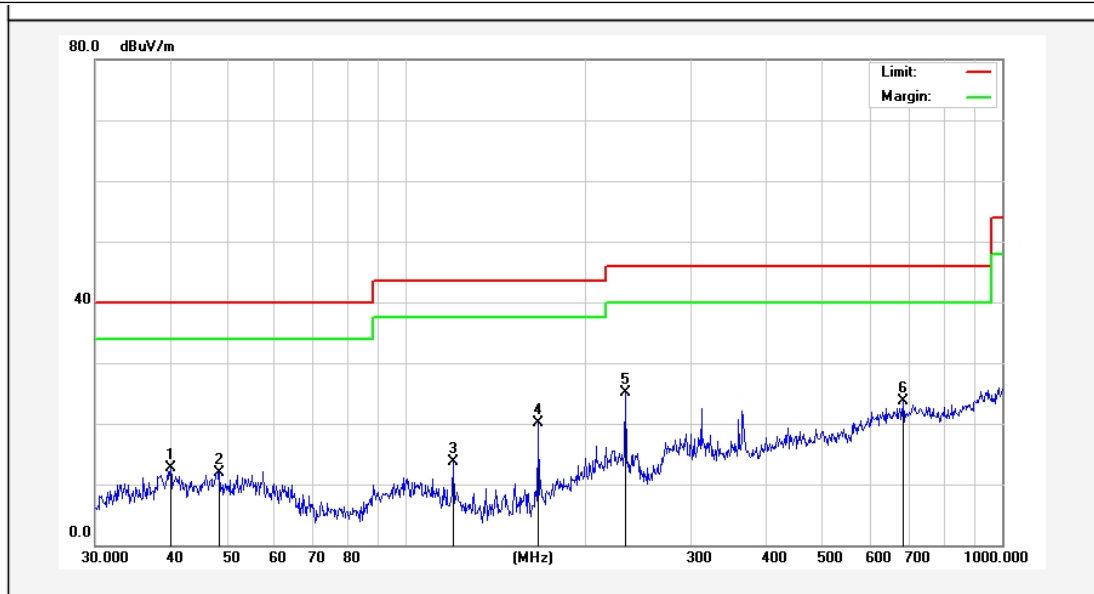
10.3. Test Data

The test results of 9kHz-30MHz was attenuated more than 20dB below the permissible limits, so the results don't record in the report.

Temperature:	22.5 °C	Humidity:	55 %	Atmospheric Pressure:	101 kPa
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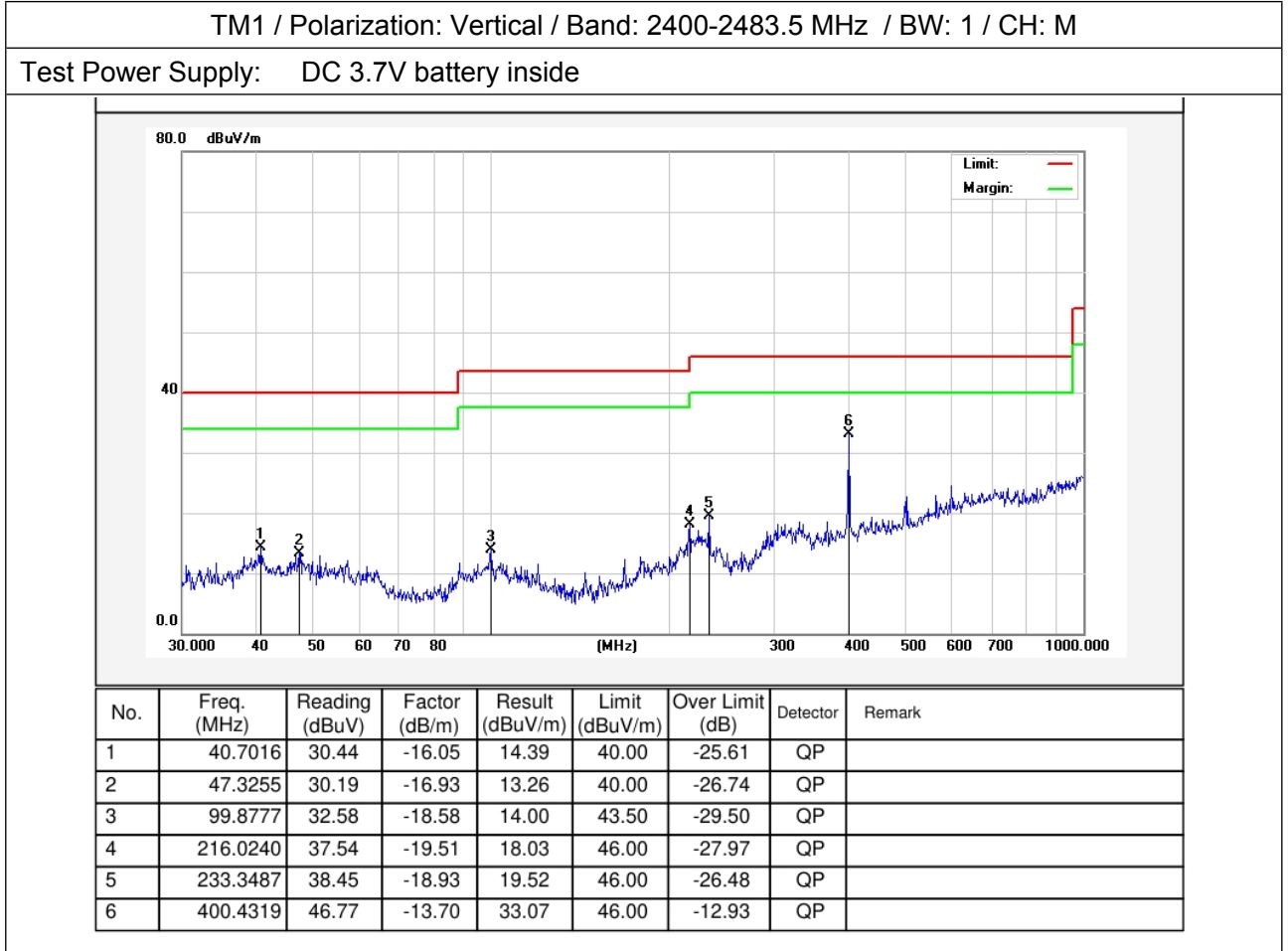
TM1 / Polarization: Horizontal / Band: 2400-2483.5 MHz / BW: 1 / CH: M

Test Power Supply: DC 3.7V battery inside



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Detector	Remark
1	40.1347	28.76	-15.97	12.79	40.00	-27.21	QP	
2	48.5016	29.08	-17.09	11.99	40.00	-28.01	QP	
3	119.8556	34.62	-20.88	13.74	43.50	-29.76	QP	
4	166.6514	42.03	-21.97	20.06	43.50	-23.44	QP	
5	232.5318	44.02	-18.98	25.04	46.00	-20.96	QP	
6	682.3484	32.63	-9.01	23.62	46.00	-22.38	QP	

Temperature:	22.5 °C	Humidity:	55 %	Atmospheric Pressure:	101 kPa
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Note:

1. Only record the worst data in the report.
2. $\text{Result(dBuV/m)} = \text{Reading(dBuV)} + \text{Factor(dB/m)}$;
 $\text{Over Limit(dB)} = \text{Result(dBuV/m)} - \text{Limit(dBuV/m)}$

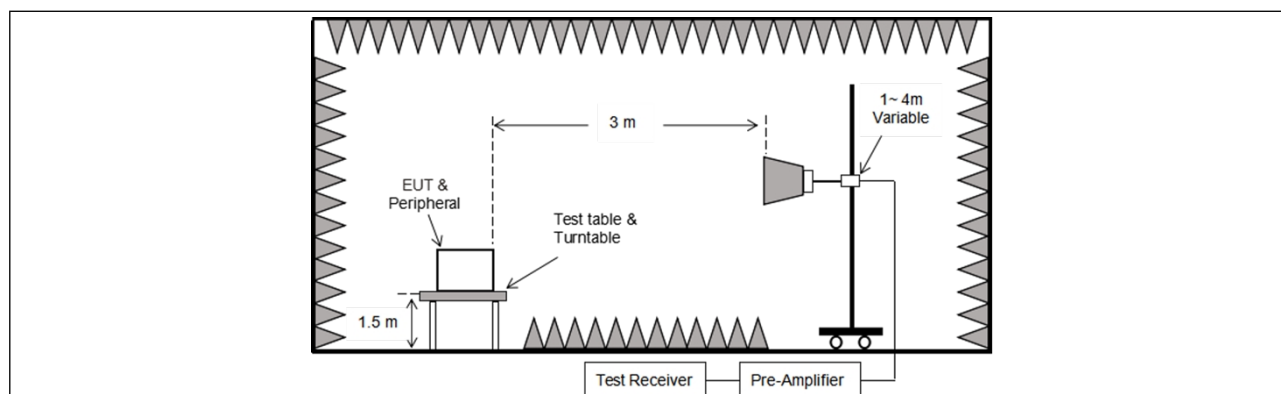
11. Emissions in restricted frequency bands (above 1GHz)

Test Requirement:	Refer to 47 CFR 15.247(d), in addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a)(see § 15.205(c)).`		
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)
	0.009-0.490	2400/F(kHz)	300
	0.490-1.705	24000/F(kHz)	30
	1.705-30.0	30	30
	30-88	100 **	3
	88-216	150 **	3
	216-960	200 **	3
	Above 960	500	3
	** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241. In the emission table above, the tighter limit applies at the band edges. The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9–90 kHz, 110–490 kHz and above 1000 MHz. Radiated emission limits in these three bands are based on measurements employing an average detector.		
Test Method:	ANSI C63.10-2020 section 6.6.4 KDB 558074 D01 15.247 Meas Guidance v05r02		
Procedure:	ANSI C63.10-2020 section 6.6.4		

11.1. EUT Operation

Operating Environment:	
Test mode:	1: TX (Non-Hopping): Keep the EUT in continuously transmitting mode (non-hopping).

11.2. Test Setup



11.3. Test Data

Temperature:	26.1 °C	Humidity:	53 %	Atmospheric Pressure:	101 kPa
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TM1 / CH: L						
Peak value:						
Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	polarization
4810.00	29.14	15.27	44.41	74.00	-29.59	Vertical
7215.00	30.29	18.09	48.38	74.00	-25.62	Vertical
9620.00	31.51	23.76	55.27	74.00	-18.73	Vertical
12025.00	*			74.00		Vertical
14430.00	*			74.00		Vertical
4810.00	29.51	15.27	44.78	74.00	-29.22	Horizontal
7215.00	30.16	18.09	48.25	74.00	-25.75	Horizontal
9620.00	29.33	23.76	53.09	74.00	-20.91	Horizontal
12025.00	*			74.00		Horizontal
14430.00	*			74.00		Horizontal
Average value:						
Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	polarization
4810.00	18.52	15.27	33.79	54.00	-20.21	Vertical
7215.00	19.32	18.09	37.41	54.00	-16.59	Vertical
9620.00	20.53	23.76	44.29	54.00	-9.71	Vertical
12025.00	*			54.00		Vertical
14430.00	*			54.00		Vertical
4810.00	17.86	15.27	33.13	54.00	-20.87	Horizontal
7215.00	19.22	18.09	37.31	54.00	-16.69	Horizontal
9620.00	18.64	23.76	42.40	54.00	-11.60	Horizontal
12025.00	*			54.00		Horizontal
14430.00	*			54.00		Horizontal

TM1 / CH: M						
Peak value:						
Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	polarization
4882.00	29.16	15.42	44.58	74.00	-29.42	Vertical
7323.00	30.14	18.02	48.16	74.00	-25.84	Vertical
9764.00	30.52	23.80	54.32	74.00	-19.68	Vertical
12205.00	*			74.00		Vertical
14646.00	*			74.00		Vertical
4882.00	29.21	15.42	44.63	74.00	-29.37	Horizontal
7323.00	30.15	18.02	48.17	74.00	-25.83	Horizontal
9764.00	29.03	23.80	52.83	74.00	-21.17	Horizontal
12205.00	*			74.00		Horizontal
14646.00	*			74.00		Horizontal
Average value:						
Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	polarization
4882.00	18.25	15.42	33.67	54.00	-20.33	Vertical
7323.00	19.42	18.02	37.44	54.00	-16.56	Vertical
9764.00	20.39	23.80	44.19	54.00	-9.81	Vertical
12205.00	*			54.00		Vertical
14646.00	*			54.00		Vertical
4882.00	17.77	15.42	33.19	54.00	-20.81	Horizontal
7323.00	18.78	18.02	36.80	54.00	-17.20	Horizontal
9764.00	19.15	23.80	42.95	54.00	-11.05	Horizontal
12205.00	*			54.00		Horizontal
14646.00	*			54.00		Horizontal

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TM1 / CH: H						
Peak value:						
Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	polarization
4950.00	29.43	15.58	45.01	74.00	-28.99	Vertical
7425.00	30.15	17.93	48.08	74.00	-25.92	Vertical
9900.00	31.07	23.83	54.90	74.00	-19.10	Vertical
12375.00	*			74.00		Vertical
14850.00	*			74.00		Vertical
4950.00	29.28	15.58	44.86	74.00	-29.14	Horizontal
7425.00	30.18	17.93	48.11	74.00	-25.89	Horizontal
9900.00	29.71	23.83	53.54	74.00	-20.46	Horizontal
12375.00	*			74.00		Horizontal
14850.00	*			74.00		Horizontal
Average value:						
Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	polarization
4950.00	19.37	15.58	34.95	54.00	-19.05	Vertical
7425.00	20.43	17.93	38.36	54.00	-15.64	Vertical
9900.00	20.94	23.83	44.77	54.00	-9.23	Vertical
12375.00	*			54.00		Vertical
14850.00	*			54.00		Vertical
4950.00	19.21	15.58	34.79	54.00	-19.21	Horizontal
7425.00	20.15	17.93	38.08	54.00	-15.92	Horizontal
9900.00	19.05	23.83	42.88	54.00	-11.12	Horizontal
12375.00	*			54.00		Horizontal
14850.00	*			54.00		Horizontal

Remark:

1. Result =Reading + Factor
2. Test frequency are from 1GHz to 25GHz, "*" means the test results were attenuated more than 20dB below the permissible limits, so the results don't record in the report.

APPENDIX I -- TEST SETUP PHOTOGRAPH

Please refer to separated files Appendix I -- Test Setup Photograph_RF

APPENDIX II -- EXTERNAL PHOTOGRAPH

Please refer to separated files Appendix II -- External Photograph

APPENDIX III -- INTERNAL PHOTOGRAPH

Please refer to separated files Appendix III -- Internal Photograph

----- End of Report -----

